

<b>Notice of References Cited</b>	Application/Control No. 09/842,128	Applicant(s)/Patent Under Reexamination TEO ET AL.	
	Examiner Sharad Rampuria	Art Unit 2683	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,415,163 B1	07-2002	Keskitalo et al.	455/562.1
	B	US-6,131,016 A	10-2000	Greenstein et al.	455/69
	C	US-6,678,527 B1	01-2004	Rasanen, Juha	455/450
	D	US-6,512,797 B1	01-2003	Tellado et al.	375/261
	E	US-6,397,082 B1	05-2002	Searle, Jeffrey Graham	455/562.1
	F	US-6,330,459 B1	12-2001	Crichton et al.	455/562.1
	G	US-2003/0195017 A1	10-2003	Chen et al.	455/562.1
	H	US-5,615,409 A	03-1997	Forssen et al.	455/440
	I	US-2004/0067775 A1	04-2004	Dalal et al.	455/562.1
	J	US-6,771,987 B1	08-2004	Dam et al.	455/562.1
	K	US-6,597,927 B1	07-2003	Eswara et al.	370/334
	L	US-5,907,816 A	05-1999	Newman et al.	455/562.1
	M	US-6,370,369 B1	04-2002	Kraiem et al.	455/277.1

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.